

Claims:-

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- Sub B1
- 5 1. A method of sensing the concentration of an oxidising gas in a gas mixture using a semiconductor gas sensor having a resistivity sensitive to the oxidising gas, which comprises increasing the sensor operating temperature to a first temperature to allow the sensor surface to reset then decreasing the sensor operating temperature to a second temperature and analysing the resultant resistance of the sensor at the second temperature.
2. A method according to claim 1 in which the first temperature is 400 to 800°C and the second temperature is 200 to 500°C.
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- 10 Sub A1
3. A method according to claim 1 or 2 wherein the sensor resistance is analyzed as a function of time.
4. A method according to any preceding claim in which the oxidising gas is NO₂, NO, Cl₂, or O₃.
- 15 5. A method according to any preceding claim in which the sensor is a layer of WO₃, In₂O₃, MoO₃ or SnO₂.
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6. A method according to claim 5 wherein the sensor is a layer of WO₃ and the oxidising gas is O₃.
- Add A2

AMENDED SHEET